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9/2011—Revision 0: Initial Version

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SPECIFICATIONS

All voltages relative to ground (Pin 2); $4.5 \text{ V} \le V_{CC} \le 5.5 \text{ V}$. $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$, $R_L = 60 \Omega$, $I_{RS} > -10 \mu\text{A}$, unless otherwise noted. All typical specifications are at $T_A = 25^{\circ}\text{C}$, $V_{CC} = 5 \text{ V}$, unless otherwise noted.

Parameter	Symbol	Min	Тур	Мах	Unit	Test Conditions/Comments
SUPPLY CURRENT			-76			
Dominant State	ice			78	mA	$V_{TxD} = 1 V$
Recessive State				10	mA	$V_{\text{TxD}} = 4 \text{ V}; \text{ R}_{\text{SLOPE}} = 47 \text{ k}\Omega$
Standby State			275	10	μA	$V_{RS} = V_{CC}$, $I_{TXD} = I_{RXD} = I_{VREF} = 0$ mA, $T_A < 90^{\circ}$ C
DRIVER			2,5		μ, ι	
Logic Inputs						
Input Voltage High	VIH	0.7 Vcc		V _{cc} + 0.3	v	Output recessive
Input Voltage Low	VIL	-0.3		+0.3 Vcc	v	Output dominant
CMOS Logic Input Current High	ь. Гин	-200		+30	μA	$V_{TxD} = 4 V$
CMOS Logic Input Current Low	 In	-100		-600	μA	$V_{\text{TxD}} = 1 \text{ V}$
Differential Outputs		100		000	μ, ι	
Recessive Bus Voltage	V _{CANH} , V _{CANL}	2.0		3.0	v	$V_{TxD} = 4 V, R_L = \infty$, see Figure 23
Off-State Output Leakage Current		-2		+2	mA	$-2 V < (V_{CANL}, V_{CANH}) < 7 V$
on state output Leakage current		-10		+10	mA	$-5 V < (V_{CANL}, V_{CANH}) < 36 V$
CANH Output Voltage	VCANH	3.0		4.5	V	$V_{\text{TxD}} = 1 \text{ V}$, see Figure 23
CANL Output Voltage	V _{CANL}	0.5		2.0	v	$V_{TxD} = 1 \text{ V}$, see Figure 23 $V_{TxD} = 1 \text{ V}$, see Figure 23
						-
Differential Output Voltage	Vod	1.5		3.0	V	$V_{TxD} = 1 V$, see Figure 23
	V _{OD}	1.5			V,	$V_{TxD} = 1 V, R_L = 45 \Omega$, see Figure 23
	Vod	-500		+50	mV	$V_{TxD} = 4 V, R_L = \infty$, see Figure 23
Short-Circuit Current, CANH	ISCCANH			-200	mA	$V_{CANH} = -5 V$
	ISCCANH		-100		mA	$V_{CANH} = -36 V$
Short-Circuit Current, CANL	ISCCANL			200	mA	$V_{CANL} = 36 V$
RECEIVER						
Differential Inputs						
Voltage Recessive	V _{IDR}	-1.0		+0.5	V	$-2 V < V_{CANL}$, $V_{CANH} < 7 V$, see Figure 25, $V_{CC} = 4.75 V$ to 5.25 V, $C_L = 30 pF$
		-1.0		+0.4	V	$-7 V < V_{CANL}$, $V_{CANH} < 12 V$, see Figure 25, $C_L = 30 pF$
Voltage Dominant	VIDD	0.9		5.0	V	-2 V < V _{CANL} , V _{CANH} <7 V, see Figure 25, V _{CC} = 4.75 V to 5.25 V, C _L = 30 pF
		1.0		5.0	V	$-7 V < V_{CANL}$, $V_{CANH} < 12 V$, see Figure 25, $C_L = 30 pF^1$
Input Voltage Hysteresis	V _{HYS}		150		mV	See Figure 26
CANH, CANL Input Resistance	R _{IN}	5		25	kΩ	_
Differential Input Resistance	R _{DIFF}	20		100	kΩ	
Logic Outputs						
Output Voltage High	V _{OH}	0.8 V _{cc}		Vcc	v	$I_{OUT} = -100 \ \mu A$
Output Voltage Low	V _{OL}	0		0.2 V _{cc}	v	$I_{OUT} = 1 \text{ mA}$
	V _{OL}	0		1.5	v	$I_{OUT} = 10 \text{ mA}$
Short-Circuit Current	Ios			120	mA	$V_{OUT} = GND \text{ or } V_{CC}$
VOLTAGE REFERENCE					1	
Reference Output Voltage	VREF	2.025		3.025	v	$V_{RS} = 1 V, I_{REF} = 50 \mu A$
. 3	VREF	0.4 Vcc		0.6 V _{cc}	v	$V_{RS} = 4 V$, $ I_{REF} = 5 \mu A$
STANDBY/SLOPE CONTROL					1	
Input Voltage for Standby Mode	V _{STB}	0.75 Vcc			v	
Current for Slope Control Mode	ISLOPE	-10		-200	μA	
Slope Control Mode Voltage	VSLOPE	0.4 Vcc		0.6 V _{cc}	V	

 1 In standby, V_{CC} = 4.75 V to 5.25 V.

TIMING SPECIFICATIONS

All voltages are relative to ground (Pin 2); 4.5 V \leq V_{CC} \leq 5.5 V. T_A = -40°C to +125°C, unless otherwise noted.

Table 2.

Parameter	Symbol	Min	Тур	Max	Unit	Test Conditions/Comments
DRIVER						
Maximum Data Rate		1			Mbps	$V_{RS} = 1 V$
Propagation Delay from TxD On to Bus Active	tonTxD			50	ns	V_{RS} = 1 V, R_{L} = 60 $\Omega,$ C_{L} = 100 pF, see Figure 24, Figure 27
Propagation Delay from TxD Off to Bus Inactive	\mathbf{t}_{offTxD}		40	80	ns	V_{RS} = 1 V, R_{L} = 60 $\Omega,$ C_{L} = 100 pF, see Figure 24, Figure 27
RECEIVER						
Propagation Delay from TxD On to Receiver Active	tonRxD		55	120	ns	V_{RS} = 1 V, R_{L} = 60 $\Omega,$ C_{L} = 100 pF, see Figure 24, Figure 27
			440	600	ns	R_{SLOPE} = 47 k Ω , R_{L} = 60 Ω , C_{L} = 100 pF, see Figure 24, Figure 27
Propagation Delay from TxD Off to Receiver Inactive	\mathbf{t}_{offRxD}		90	190	ns	R_{SLOPE} = 0 Ω,R_{L} = 60 Ω,C_{L} = 100 pF, see Figure 24, Figure 27
			290	400	ns	R_{SLOPE} = 47 k Ω , R_{L} = 60 Ω , C_{L} = 100 pF, see Figure 24, Figure 27
Bus Dominant to RxD Low	\mathbf{t}_{dRxDL}			3	μs	V_{RS} = 4 V, V_{TxD} = 4 V, R_{L} = 60 $\Omega,$ C_{L} = 100 pF, see Figure 24, Figure 29
CANH, CANL Slew Rate	SR		7		V/µs	$R_{SLOPE} = 47 \text{ k}\Omega$, $R_L = 60 \Omega$, $C_L = 100 \text{ pF}$, see Figure 24, Figure 27
TIME TO WAKE-UP FROM STANDBY	twake			20	μs	V _{TxD} = 1 V, see Figure 28

ABSOLUTE MAXIMUM RATINGS

Table 3.

1 4010 01	
Parameter	Rating
Vcc	–0.3 V to +7 V
Digital Input Voltage	
TxD	-0.3 V to V _{CC} + 0.3 V
Digital Output Voltage	
RxD	-0.3 V to V _{CC} + 0.3 V
CANH, CANL	-36 V to +36 V
V _{REF}	-0.3 V to V_{CC} + 0.3 V
RS	-0.3 V to V _{CC} + 0.3 V
Operating Temperature Range	-40°C to +125°C
Storage Temperature Range	–55°C to +150°C
ESD (Human Body Model) on All Pins	4 kV
Lead Temperature	
Soldering (10 sec)	300°C
Vapor Phase (60 sec)	215°C
Infrared (15 sec)	220°C
θ _{JA} Thermal Impedance	110°C/W
T _J Junction Temperature	150°C

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

ESD CAUTION



ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

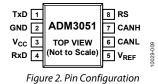


Table 4. Pin Function Descriptions

Pin No.	Mnemonic	Description
1	TxD	Driver Input Data.
2	GND	Ground.
3	Vcc	Power Supply. This pin requires a decoupling capacitor to GND of 100 nF.
4	RxD	Receiver Output Data.
5	V _{REF}	Reference Voltage Output.
6	CANL	Low Level CAN Voltage Input/Output.
7	CANH	High Level CAN Voltage Input/Output.
8	RS	Slope Resistor Input.

TYPICAL PERFORMANCE CHARACTERISTICS

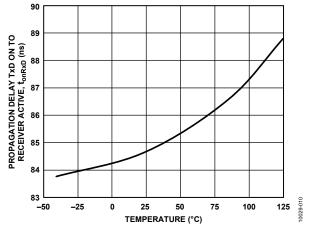


Figure 3. Propagation Delay from TxD On to Receiver Active vs. Temperature

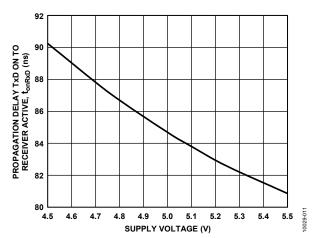


Figure 4. Propagation Delay from TxD On to Receiver Active vs. Supply Voltage

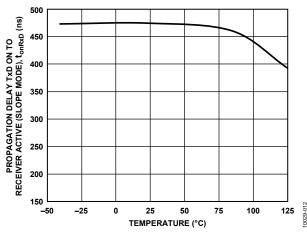


Figure 5. Propagation Delay (Slope Control Mode, $R_{SLOPE} = 47 \text{ k}\Omega$) from TxD On to Receiver Active vs. Temperature

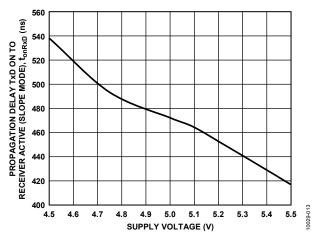
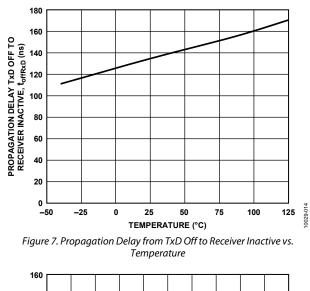
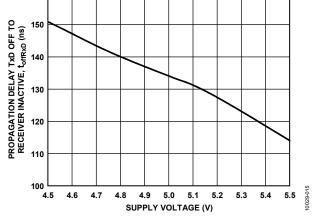
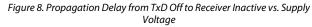


Figure 6. Propagation Delay (Slope Control Mode, $R_{SLOPE} = 47 \text{ k}\Omega$) from TxD On to Receiver Active vs. Supply Voltage







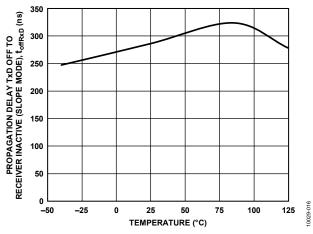


Figure 9. Propagation Delay (Slope Control Mode, $R_{SLOPE} = 47 \text{ k}\Omega$) from TxD Off to Receiver Inactive vs. Temperature

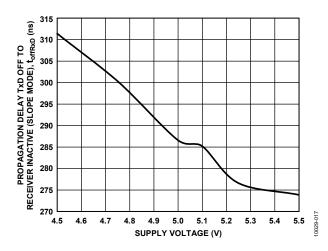


Figure 10. Propagation Delay (Slope Control Mode, $R_{SLOPE} = 47 k\Omega$) from TxD Off to Receiver Inactive vs. Supply Voltage

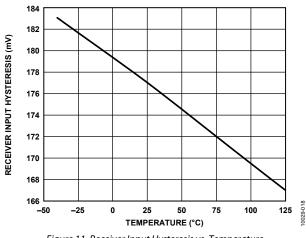


Figure 11. Receiver Input Hysteresis vs. Temperature

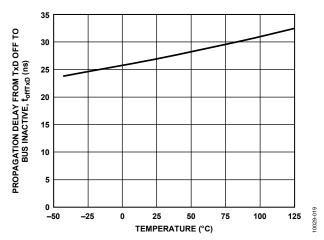


Figure 12. Propagation Delay from TxD Off to Bus Inactive vs. Temperature

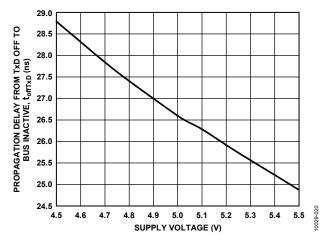


Figure 13. Propagation Delay from TxD Off to Bus Inactive vs. Supply Voltage

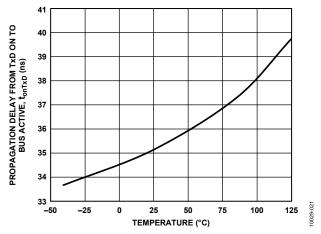


Figure 14. Propagation Delay from TxD On to Bus Active vs. Temperature

Data Sheet

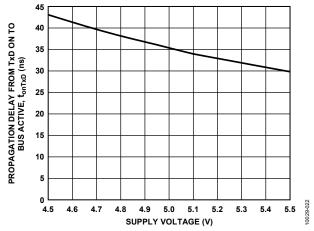


Figure 15. Propagation Delay from TxD On to Bus Active vs. Supply Voltage

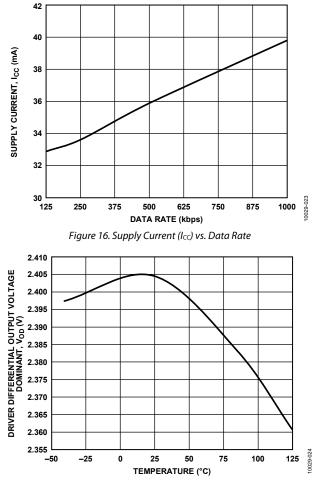
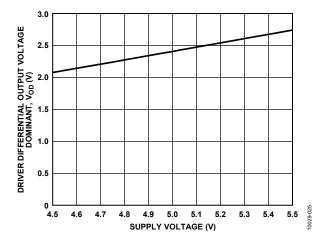


Figure 17. Driver Differential Output Voltage Dominant vs. Temperature



ADM3051

Figure 18. Driver Differential Output Voltage Dominant vs. Supply Voltage

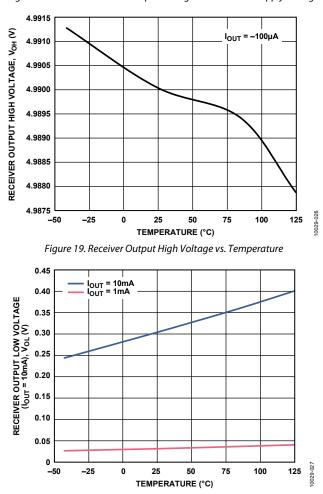
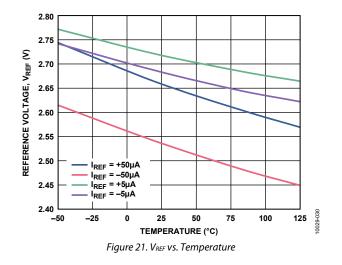
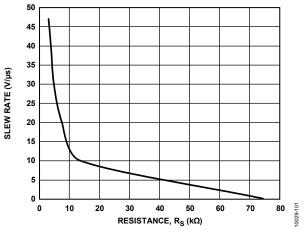


Figure 20. Receiver Output Low Voltage vs. Temperature







TEST CIRCUITS AND SWITCHING CHARACTERISTICS

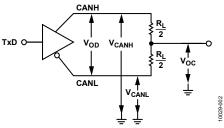


Figure 23. Driver Voltage Measurements

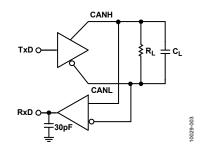
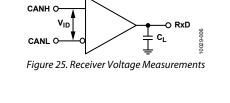
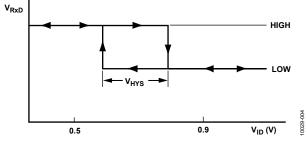
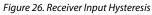
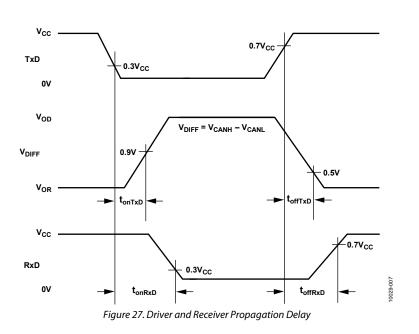


Figure 24. Switching Characteristics Measurements









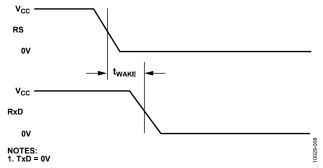
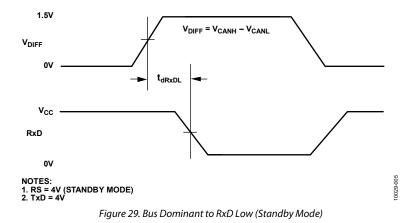


Figure 28. Wake-Up Delay Returning from Standby Mode

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CIRCUIT DESCRIPTION CAN TRANSCEIVER OPERATION

A CAN bus has two states: dominant and recessive. A dominant state is present on the bus when the differential voltage between CANH and CANL is greater than 0.9 V. A recessive state is present on the bus when the differential voltage between CANH and CANL is less than 0.5 V. During a dominant bus state, the CANH pin is high and the CANL pin is low. During a recessive bus state, both the CANH and CANL pins are in the high impedance state.

The driver drives CANH high and CANL low (dominant state) if a logic low is present on TxD. If a logic high is present on TxD, the driver output is placed in a high impedance state (recessive state). The driver output states are shown in Table 7.

The receiver output is low if the bus is in the dominant state and high if the bus is in the recessive state. If the differential voltage between CANH and CANL is between 0.5 V and 0.9 V, the bus state is indeterminate and the receiver output may be high or low. The receiver output states for given inputs are listed in Table 8.

OPERATIONAL MODES

Three modes of operation are available: high speed, slope control, and standby. RS (Pin 8) allows modification of the operational mode by connecting the RS input through a resistor to ground, or directly to ground, or to a CAN controller, as shown in Figure 30.

With RS connected to ground, the output transistors switch on and off at the maximum rate possible in high speed mode, with no modification to the rise and fall slopes. EMI in this mode can be alleviated using shielded cables.

Alternatively, connecting RS to a resistor, R_{SLOPE} , allows slope control mode, with the value of the resistor modifying the rise and fall slopes. The reduced EMI allows the use of unshielded cables.

Applying a logic high to RS initiates a low current standby mode. The transmitter is disabled, and the receiver is connected to a low current. RxD goes low upon receiving dominant bits, allowing an attached microcontroller that detects this to wake the transceiver via Pin 8, which returns it to standard operation. The receiver is slower in standby mode and loses the first message at higher bit rates.

Table 5. Mode Selection Using RS Pin (Pin 8)

Mode	Condition to Force	Resulting Voltage/Current
Standby	$V_{RS} > 0.75 V_{CC}$	-I _{RS} < 10 μA
Slope Control	$10 \ \mu A < -I_{RS} < 200 \ \mu A$	$0.4 V_{CC} < V_{RS} < 0.6 V_{CC}$
High Speed	$V_{RS} < 0.3 V_{CC}$	–I _{RS} < –500 μΑ

TRUTH TABLES

The truth tables in this section use the abbreviations found in Table 6.

Table 6. Truth Table Abbreviations

Letter	Description
Н	High level
L	Low level
Х	Don't care
I	Indeterminate
Z	High impedance (off)
NC	Disconnected

Table 7. Transmitting

Supply	Input		Outputs				
Vcc	TxD	State	CANH	CANL			
On	L	Dominant	Н	L			
On	н	Recessive	Z	Z			
On	Z	Recessive	Z	Z			
Off	Х	Z	Z	Z			

Table 8. Receiving

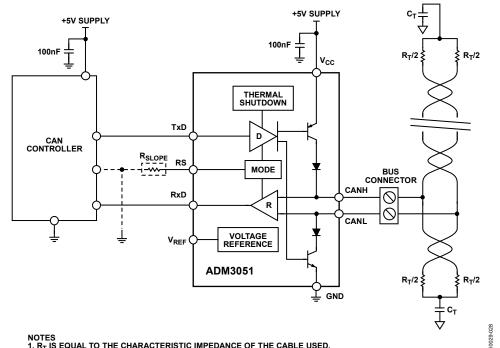
Supply	Inputs	Output	
Vcc	$V_{ID} = CANH - CANL$	Bus State	RxD
On	≥0.9 V	Dominant	L
On	≤0.5 V	Recessive	Н
On	$0.5 \ V < V_{ID} < 0.9 \ V$	I	1
On	Inputs open	Recessive	н
Off	Х	Х	I

THERMAL SHUTDOWN

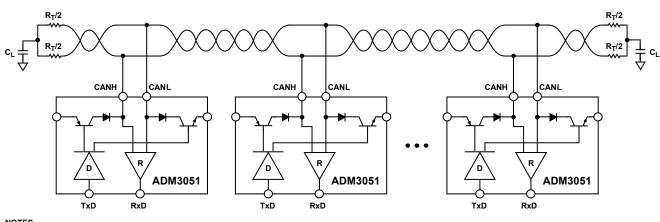
The ADM3051 contains thermal shutdown circuitry that protects the part from excessive power dissipation during fault conditions. Shorting the driver outputs to a low impedance source can result in high driver currents. The thermal sensing circuitry detects the increase in die temperature under this condition and disables the driver outputs. The design of this circuitry ensures the disabling of driver outputs upon reaching a die temperature of 150°C. As the device cools, reenabling of the drivers occurs at a temperature of 140°C.

10029-029

APPLICATIONS INFORMATION



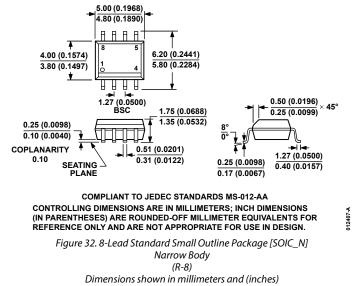
NOTES 1. $R_{\rm T}$ IS EQUAL TO THE CHARACTERISTIC IMPEDANCE OF THE CABLE USED. Figure 30. Typical CAN Node Using the ADM3051



NOTES 1. MAXIMUM NUMBER OF NODES: 110. 2. $R_{\rm T}$ IS EQUAL TO THE CHARACTERISTIC IMPEDANCE OF THE CABLE USED.

Figure 31. Typical CAN Network

OUTLINE DIMENSIONS



ORDERING GUIDE

Model ¹	Temperature Range	Package Description	Package Option
ADM3051CRZ	-40°C to +125°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8
ADM3051CRZ-REEL7	-40°C to +125°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8
EVAL-ADM3051EBZ		Evaluation Board	

¹ Z = RoHS Compliant Part.

NOTES

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